P-Channel 20 V (D-S) MOSFET

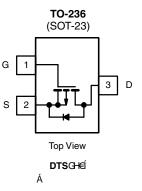
PRODUCT SUMMARY						
V _{DS} (V)	R _{DS(on)} (Ω)	I _D (A) ^a	Q _g (Typ.)			
- 20	0.065 at V _{GS} = - 4.5 V	- 4				
	0.090 at V _{GS} = - 2.5 V	- 3.8	7.6 nC			
	0.110 at V _{GS} = - 1.8 V	- 3.3	7.0110			
	0.165 at V _{GS} = - 1.5 V	- 0.5				

FEATURES

- Halogen-free According to IEC 61249-2-21
 Definition
- TrenchFET[®] Power MOSFET
- 100 % Rg Tested
- Typical ESD Performance 1200 V
- AEC-Q101 Qualifiedc
- Compliant to RoHS Directive 2002/95/EC

APPLICATIONS

• Load Switch for Portable Devices



Ordering Information: DTS2305 (Lead (Pb)-free and Halogen-free)

Parameter		Symbol	Limit	Unit	
Drain-Source Voltage		V _{DS}	- 20	v	
Gate-Source Voltage		V _{GS}	± 8	V	
	T _C = 25 °C		- 4		
Continuous Drain Current (T 150 °C)	T _C = 70 °C		- 3.5		
Continuous Drain Current (T _J = 150 °C)	T _A = 25 °C	I _D	- 3.7 ^{b, c}		
	T _A = 70 °C		- 2.9 ^{b, c}	A	
Pulsed Drain Current		I _{DM}	- 20		
Continuous Source-Drain Diode Current	T _C = 25 °C	I	- 1.5		
Continuous Source-Drain Diode Current	T _A = 25 °C	I _S	- 1.0 ^{b, c}		
	T _C = 25 °C		1.8		
Maximum Power Dissipation	T _C = 70 °C	Р	1.1	w	
Maximum Fower Dissipation	T _A = 25 °C	P _D	1.25 ^{b, c}	vv	
	T _A = 70 °C		0.8 ^{b, c}	7	
Operating Junction and Storage Temperature R	T _J , T _{stg}	- 55 to 150			
Soldering Recommendations (Peak Temperatur		260			

THERMAL RESISTANCE RATINGS						
Parameter		Symbol	Typical	Maximum	Unit	
Maximum Junction-to-Ambient ^{b, d}	t ≤ 5 s	R _{thJA}	80	100	°C/W	
Maximum Junction-to-Foot (Drain)	Steady State	R _{thJF}	55	70	0/11	

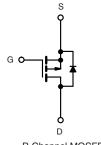
Notes: a. T_C = 25 °C.

b. Surface Mounted on 1" x 1" FR4 board.

c. t = 5 s.

d. Maximum under Steady State conditions is 130 °C/W.





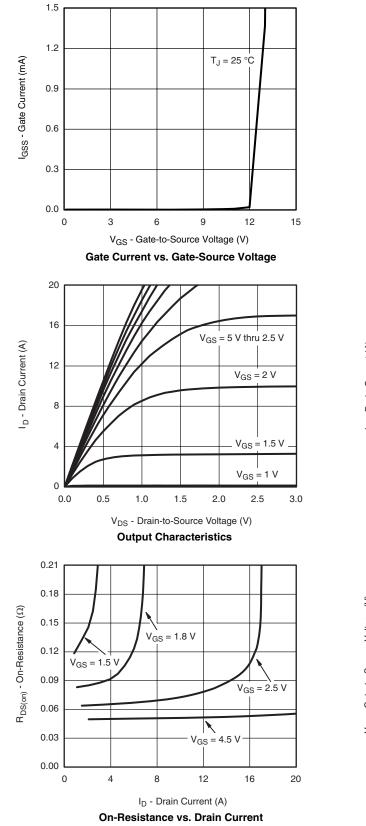
P-Channel MOSFET

Parameter	Symbol	Test Conditions	Min.	Тур.	Max.	Unit	
Static					1		
Drain-Source Breakdown Voltage	V _{DS}	$V_{GS} = 0 \text{ V}, \text{ I}_{D} = -250 \mu\text{A}$	- 20			V	
V _{DS} Temperature Coefficient	$\Delta V_{DS}/T_{J}$	050.00		- 13		-1/0	
V _{GS(th)} Temperature Coefficient	$\Delta V_{GS(th)}/T_J$	$I_{\rm D} = -250 \mu{\rm A}$		2.5		mV/°0	
Gate-Source Threshold Voltage	V _{GS(th)}	$V_{DS} = V_{GS}, I_{D} = -250 \ \mu A$	- 0.4		- 1	V	
		$V_{DS} = 0 V, V_{GS} = \pm 8 V$			± 6	- μΑ	
Gate-Source Leakage	I _{GSS}	$V_{DS} = 0 V, V_{GS} = \pm 4.5 V$			± 0.5		
	I _{DSS}	$V_{DS} = -20 V, V_{GS} = 0 V$			- 1		
Zero Gate Voltage Drain Current		$V_{DS} = -20 \text{ V}, V_{GS} = 0 \text{ V}, T_{J} = 55 ^{\circ}\text{C}$			- 10	1	
On-State Drain Current ^a	I _{D(on)}	$V_{DS} \le$ - 5 V, V_{GS} = - 4.5 V	- 15			Α	
		V _{GS} = - 4.5 V, I _D = - 3.2 A		0.050	0.065		
	_	V _{GS} = - 2.5 V, I _D = - 2.8 A		0.065	0.090	Ω	
Drain-Source On-State Resistance ^a	R _{DS(on)}	V _{GS} = - 1.8 V, I _D = - 1.5 A		0.090	0.110		
		V _{GS} = - 1.5 V, I _D = - 0.5 A		0.110	0.165		
Forward Transconductance ^a	g _{fs}	V _{DS} = - 10 V, I _D = - 3.2 A		12		S	
Dynamic ^b	0.0						
Total Gate Charge		V _{DS} = - 10 V, V _{GS} = - 8 V, I _D = - 5.3 A		14 21			
	Qg	$V_{DS} = -10 \text{ V}, \text{ V}_{GS} = -4.5 \text{ V}, \text{ I}_{D} = -5.3 \text{ A}$		7.6	12	nC	
Gate-Source Charge	Q _{gs}			0.8			
Gate-Drain Charge	Q _{gd}			3.1			
Gate Resistance	R _g	f = 1 MHz	0.4	2	4	kΩ	
Turn-On Delay Time	t _{d(on)}			0.20	0.3		
Rise Time	t _r	V_{DD} = - 10 V, R _L = 2.3 Ω		1.00	1.50	-	
Turn-Off Delay Time	t _{d(off)}	$I_D \cong$ - 4.3 A, V_{GEN} = - 4.5 V, R_g = 1 Ω		4.00	6.00		
Fall Time	t _f			2.00	3.00		
Turn-On Delay Time	t _{d(on)}			0.09	0.14	μs	
Rise Time	t _r	$V_{DD} = -10 \text{ V}, \text{ R}_{1} = 2.3 \Omega$		0.40	0.60	1	
Turn-Off Delay Time	$t_{d(off)}$ $I_D \cong$ - 4.3 A, V_{GEN} = -8 V, R_g = 1 Ω			5.20	7.80	1	
Fall Time	t _f	, i i i i i i i i i i i i i i i i i i i		2.30	3.50	1	
Drain-Source Body Diode Characterist				I	I		
Continuous Source-Drain Diode Current	۱ _S	T _C = 25 °C			- 1.5		
Pulse Diode Forward Current	I _{SM}				- 20	A	
Body Diode Voltage	V _{SD}	I _S = - 3 A, V _{GS} = 0 V		- 0.8	- 1.2	V	
Body Diode Reverse Recovery Time	t _{rr}			30	60	ns	
Body Diode Reverse Recovery Charge	Q _{rr}			20	40	nC	
Reverse Recovery Fall Time	t _a	$I_F = -3 \text{ A}, \text{ dl/dt} = 100 \text{ A/}\mu\text{s}, \text{ T}_J = 25 ^\circ\text{C}$		13			
Reverse Recovery Rise Time	t _b			17		ns	

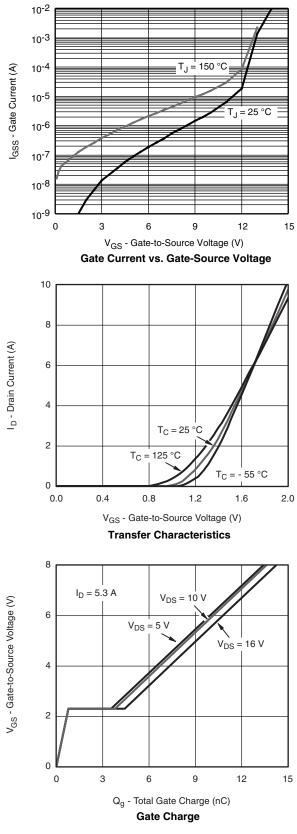
Notes:

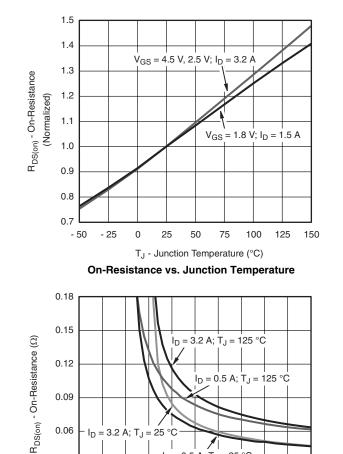
a. Pulse test; pulse width \leq 300 μ s, duty cycle \leq 2 %. b. Guaranteed by design, not subject to production testing.

Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.









I_D = 3.2 A; T_J = 25 °C

0.03

0.00

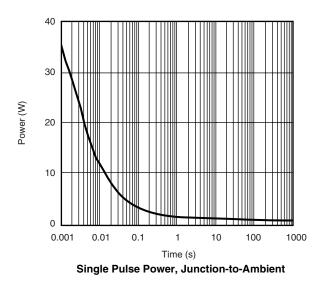
 $I_D = 0.5 \text{ A}; T_J = 25 \text{ °C}$

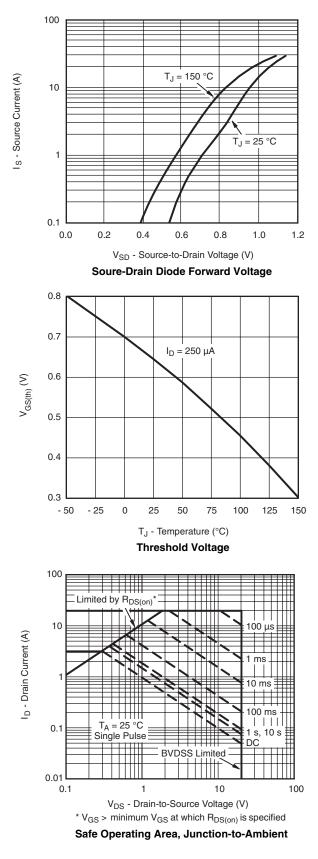
0.0 0.5 1.0 1.5 2.0 2.5 3.0 3.5 4.0 4.5 5.0

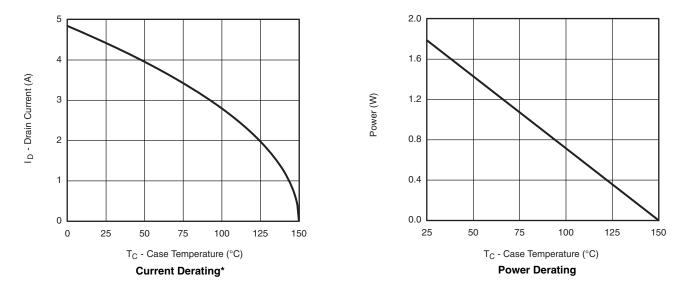
V_{GS} - Gate-to-Source Voltage (V)

On-Resistance vs. Gate-to-Source Voltage

TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted

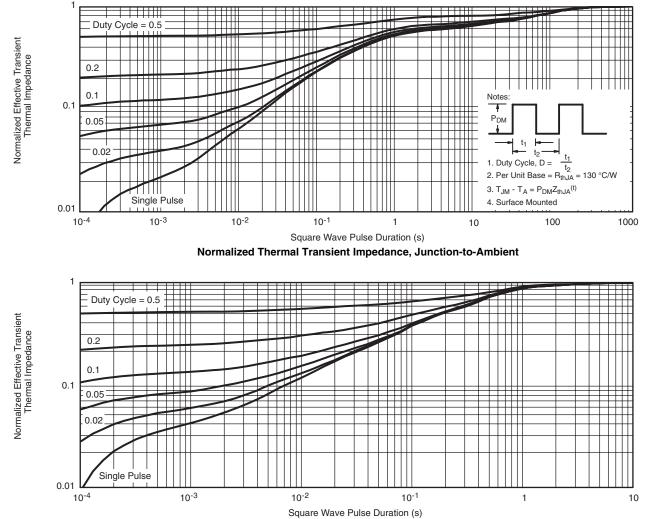






TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted

* The power dissipation P_D is based on $T_{J(max)}$ = 150 °C, using junction-to-case thermal resistance, and is more useful in settling the upper dissipation limit for cases where additional heatsinking is used. It is used to determine the current rating, when this rating falls below the package limit.



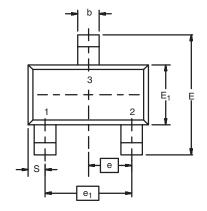
TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted

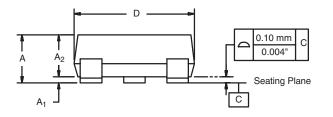
Normalized Thermal Transient Impedance, Junction-to-Foot

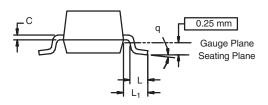
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SOT-23 (TO-236): 3-LEAD



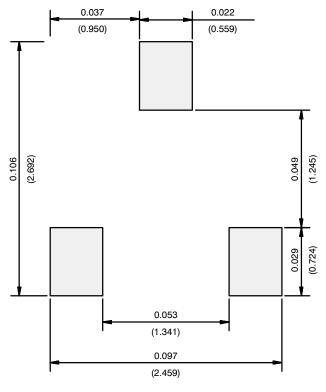




Dim		NETERS	INCHES		
	Min	Max	Min	Max	
Α	0.89	1.12	0.035	0.044	
A ₁	0.01	0.10	0.0004	0.004	
A ₂	0.88	1.02	0.0346	0.040	
b	0.35	0.50	0.014	0.020	
C	0.085	0.18	0.003	0.007	
D	2.80	3.04	0.110	0.120	
E	2.10	2.64	0.083	0.104	
E ₁	1.20	1.40	0.047	0.055	
е	0.95 BSC		0.0374 Ref		
e ₁	1.90 BSC		0.0748 Ref		
L	0.40	0.60	0.016	0.024	
L ₁	0.64 Ref		0.025	Ref	
S	0.50 Ref		0.020	Ref	
q	3°	8°	3°	8°	



RECOMMENDED MINIMUM PADS FOR SOT-23



Recommended Minimum Pads Dimensions in Inches/(mm)

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